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# R1LP0408C-I Series

Wide Temperature Range Version 4M SRAM (512-kword × 8-bit)

REJ03C0067-0200Z Rev. 2.00 May.26.2004

## **Description**

The R1LP0408C-I is a 4-Mbit static RAM organized 512-kword × 8-bit. R1LP0408C-I Series has realized higher density, higher performance and low power consumption by employing CMOS process technology (6-transistor memory cell). The R1LP0408C-I Series offers low power standby power dissipation; therefore, it is suitable for battery backup systems. It has packaged in 32-pin SOP, 32-pin TSOP II.

#### **Features**

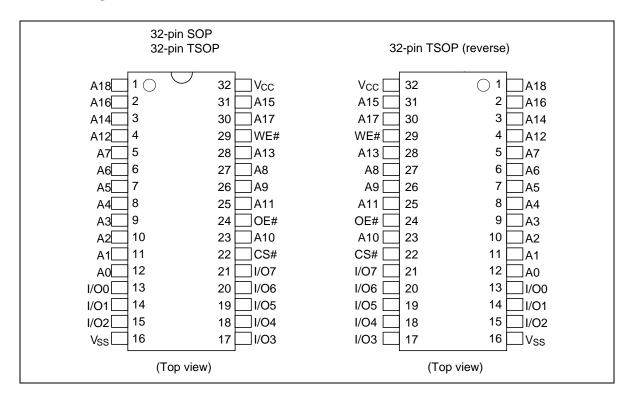
- Single 5 V supply: 5 V ± 10%
  Access time: 55/70 ns (max)
- Power dissipation:
  - Active: 10 mW/MHz (typ)
  - Standby:  $4 \mu W (typ)$
- Completely static memory.
  - No clock or timing strobe required
- Equal access and cycle times
- Common data input and output.
  - Three state output
- Directly TTL compatible.
  - All inputs and outputs
- Battery backup operation.
- Operating temperature: -40 to +85°C

# R1LP0408C-I Series

# **Ordering Information**

Type No.	Access time	Package
R1LP0408CSP-5SI	55 ns	525-mil 32-pin plastic SOP (32P2M-A)
R1LP0408CSP-7LI	70 ns	_
R1LP0408CSB-5SI	55 ns	400-mil 32-pin plastic TSOP II (32P3Y-H)
R1LP0408CSB-7LI	70 ns	
R1LP0408CSC-5SI	55 ns	400-mil 32-pin plastic TSOP II reverse (32P3Y-J)
R1LP0408CSC-7LI	70 ns	_

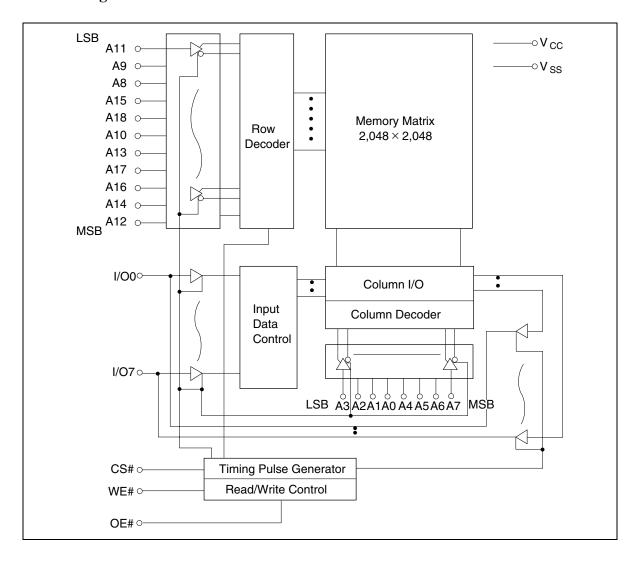
### **Pin Arrangement**



#### **Pin Description**

Pin name	Function
A0 to A18	Address input
I/O0 to I/O7	Data input/output
CS# (CS)	Chip select
OE# (OE)	Output enable
WE# (WE)	Write enable
V <sub>CC</sub>	Power supply
V <sub>SS</sub>	Ground

### **Block Diagram**



# **Operation Table**

WE#	CS#	OE#	Mode	V <sub>CC</sub> current	I/O0 to I/O7	Ref. cycle
×	Н	×	Not selected	I <sub>SB</sub> , I <sub>SB1</sub>	High-Z	_
Н	L	Н	Output disable	I <sub>CC</sub>	High-Z	_
Н	L	L	Read	I <sub>CC</sub>	Dout	Read cycle
L	L	Н	Write	I <sub>CC</sub>	Din	Write cycle (1)
L	L	L	Write	I <sub>CC</sub>	Din	Write cycle (2)

Note: H: V<sub>IH</sub>, L: V<sub>IL</sub>, ×: V<sub>IH</sub> or V<sub>IL</sub>

# **Absolute Maximum Ratings**

Parameter	Symbol	Value	Unit
Power supply voltage relative to V <sub>SS</sub>	V <sub>CC</sub>	-0.5 to +7.0	V
Terminal voltage on any pin relative to V <sub>SS</sub>	V <sub>T</sub>	$-0.5^{*1}$ to $V_{CC} + 0.3^{*2}$	V
Power dissipation	P <sub>T</sub>	0.7	W
Operating temperature	Topr	-40 to +85	°C
Storage temperature range	Tstg	-65 to +150	°C
Storage temperature range under bias	Tbias	-40 to +85	°C

Notes: 1.  $V_T$  min: -3.0 V for pulse half-width  $\leq 30$  ns.

2. Maximum voltage is +7.0 V.

# **DC Operating Conditions**

 $(Ta = -40 \text{ to } +85^{\circ}C)$ 

Parameter	Symbol	Min	Тур	Max	Unit
Supply voltage	$V_{CC}$	4.5	5.0	5.5	V
	V <sub>SS</sub>	0	0	0	V
Input high voltage	V <sub>IH</sub>	2.2	_	V <sub>CC</sub> + 0.3	V
Input low voltage	V <sub>IL</sub>	-0.3* <sup>1</sup>	_	0.8	V

Note: 1.  $V_{IL}$  min: -3.0 V for pulse half-width  $\leq 30$  ns.

### **DC** Characteristics

Parameter			Symbol	Min	Тур	Max	Unit	Test conditions
Input leakage cur	rent		I <sub>LI</sub>	_	_	1	μΑ	Vin = V <sub>SS</sub> to V <sub>CC</sub>
Output leakage co	urrent		I <sub>LO</sub>	_	_	1	μΑ	$CS\# = V_{IH}$ or $OE\# = V_{IH}$ or $WE\# = V_{IL}$ or $V_{I/O} = V_{SS}$ to $V_{CC}$
Operating current			I <sub>CC</sub>	_	1.5* <sup>1</sup>	3	mA	$\begin{split} \text{CS\#} &= \text{V}_{\text{IL}}, \\ \text{Others} &= \text{V}_{\text{IH}}/\text{V}_{\text{IL}}, \text{I}_{\text{I/O}} = 0 \text{ mA} \end{split}$
Average operating	g current		I <sub>CC1</sub>	_	8* <sup>1</sup>	25	mA	Min. cycle, duty = 100%, $CS\# = V_{IL}$ , Others = $V_{IH}/V_{IL}$ $I_{I/O} = 0$ mA
			I <sub>CC2</sub>		2* <sup>1</sup>	5	mA	Cycle time = 1 $\mu$ s, duty = 100%, $I_{I/O} = 0$ mA, CS# $\leq$ 0.2 V, $V_{IH} \geq V_{CC} - 0.2$ V, $V_{IL} \leq$ 0.2 V
Standby current	Standby current		I <sub>SB</sub>	_	0.1* <sup>1</sup>	0.5	mA	CS# = V <sub>IH</sub>
Standby current	-5SI	to +85°C	I <sub>SB1</sub>	_	_	10	μΑ	$Vin \ge 0 \text{ V, CS\#} \ge V_{CC} - 0.2 \text{ V}$
		to +70°C	I <sub>SB1</sub>	_	_	8	μΑ	
		to +40°C	I <sub>SB1</sub>	_	1.0* <sup>2</sup>	3	μΑ	_
		to +25°C	I <sub>SB1</sub>	_	0.8*1	3	μΑ	_
	-7LI	to +85°C	I <sub>SB1</sub>	_	_	20	μΑ	_
		to +70°C	I <sub>SB1</sub>	_	_	16	μΑ	_
		to +40°C	I <sub>SB1</sub>	_	1.0*2	10	μΑ	_
		to +25°C	$I_{SB1}$	_	0.8*1	10	μΑ	
Output low voltag	Output low voltage		$V_{OL}$			0.4	V	$I_{OL} = 2.1 \text{ mA}$
Output high voltage	ge		V <sub>OH</sub>	2.4			V	$I_{OH} = -1.0 \text{ mA}$
			$V_{OH2}$	2.6	_	_	V	$I_{OH} = -0.1 \text{ mA}$

Notes: 1. Typical values are at  $V_{CC} = 5.0 \text{ V}$ ,  $Ta = +25^{\circ}\text{C}$  and specified loading, and not guaranteed.

2. Typical values are at  $V_{CC} = 5.0 \text{ V}$ ,  $Ta = +40^{\circ}\text{C}$  and specified loading, and not guaranteed.

# Capacitance

 $(Ta = +25^{\circ}C, f = 1.0 \text{ MHz})$ 

Parameter	Symbol	Min	Тур	Max	Unit	Test conditions	Note
Input capacitance	Cin	_	_	8	рF	Vin = 0 V	1
Input/output capacitance	C <sub>I/O</sub>	_	_	10	рF	$V_{I/O} = 0 V$	1

Note: 1. This parameter is sampled and not 100% tested.

#### **AC Characteristics**

(Ta = -40 to +85°C,  $V_{CC}$  = 5 V  $\pm$  10%, unless otherwise noted.)

#### **Test Conditions**

• Input pulse levels:  $V_{IL} = 0.4 \text{ V}$ ,  $V_{IH} = 2.4 \text{ V}$ 

• Input rise and fall time: 5 ns

• Input and output timing reference levels: 1.5 V

 $\bullet \quad Output \ load: \ \ 1 \ TTL \ Gate + C_L \ (50 \ pF) \ (R1LP0408C\text{-}5SI)$ 

1 TTL Gate + C<sub>L</sub> (100 pF) (R1LP0408C-7LI)

(Including scope and jig)

# **Read Cycle**

#### R1LP0408C-I

		-5SI		-7LI			
Parameter	Symbol	Min	Max	Min	Max	Unit	Notes
Read cycle time	t <sub>RC</sub>	55	_	70	_	ns	
Address access time	t <sub>AA</sub>	_	55		70	ns	
Chip select access time	t <sub>CO</sub>	_	55		70	ns	
Output enable to output valid	t <sub>OE</sub>	_	25		35	ns	
Chip select to output in low-Z	t <sub>LZ</sub>	10	_	10	_	ns	2
Output enable to output in low-Z	t <sub>OLZ</sub>	5	_	5	_	ns	2
Chip deselect to output in high-Z	t <sub>HZ</sub>	0	20	0	25	ns	1, 2
Output disable to output in high-Z	t <sub>OHZ</sub>	0	20	0	25	ns	1, 2
Output hold from address change	t <sub>OH</sub>	10	_	10	_	ns	

#### Write Cycle

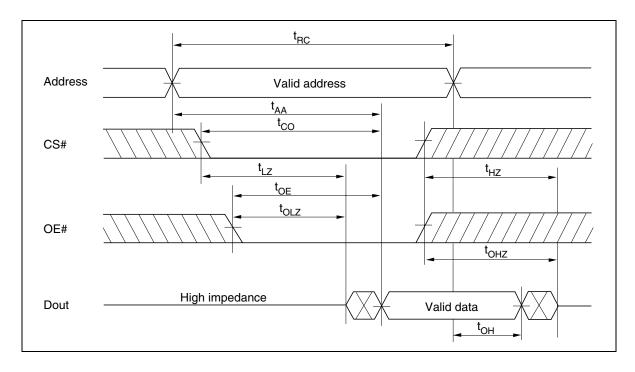
#### R1LP0408C-I

		-5SI		-7LI			
Parameter	Symbol	Min	Max	Min	Max	 Unit	Notes
Write cycle time	t <sub>WC</sub>	55		70		ns	
Chip selection to end of write	t <sub>CW</sub>	50	_	60	_	ns	4
Address setup time	t <sub>AS</sub>	0	_	0	_	ns	5
Address valid to end of write	t <sub>AW</sub>	50	_	60	_	ns	
Write pulse width	t <sub>WP</sub>	40	_	50	_	ns	3, 12
Write recovery time	t <sub>WR</sub>	0	_	0	_	ns	6
Write to output in high-Z	t <sub>WHZ</sub>	0	20	0	25	ns	1, 2, 7
Data to write time overlap	t <sub>DW</sub>	25	_	30	_	ns	
Data hold from write time	t <sub>DH</sub>	0	_	0	_	ns	
Output active from end of write	t <sub>OW</sub>	5	_	5	_	ns	2
Output disable to output in high-Z	t <sub>OHZ</sub>	0	20	0	25	ns	1, 2, 7

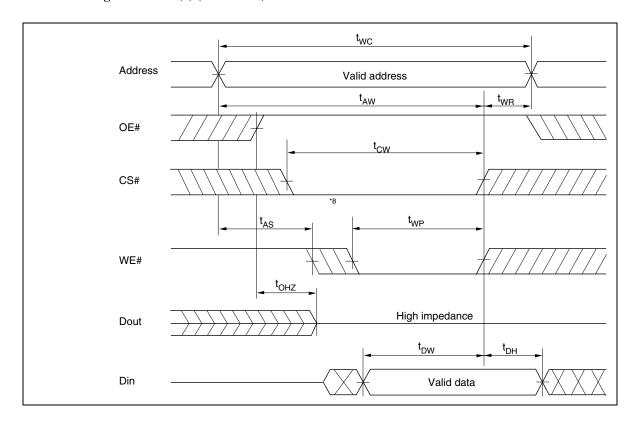
- Notes: 1.  $t_{HZ}$ ,  $t_{OHZ}$  and  $t_{WHZ}$  are defined as the time at which the outputs achieve the open circuit conditions and are not referred to output voltage levels.
  - 2. This parameter is sampled and not 100% tested.
  - 3. A write occurs during the overlap (t<sub>WP</sub>) of a low CS# and a low WE#. A write begins at the later transition of CS# going low or WE# going low. A write ends at the earlier transition of CS# going high or WE# going high. t<sub>WP</sub> is measured from the beginning of write to the end of write.
  - 4.  $t_{CW}$  is measured from CS# going low to the end of write.
  - 5. t<sub>AS</sub> is measured from the address valid to the beginning of write.
  - 6. t<sub>WR</sub> is measured from the earlier of WE# or CS# going high to the end of write cycle.
  - 7. During this period, I/O pins are in the output state so that the input signals of the opposite phase to the outputs must not be applied.
  - 8. If the CS# low transition occurs simultaneously with the WE# low transition or after the WE# transition, the output remain in a high impedance state.
  - 9. Dout is the same phase of the write data of this write cycle.
  - 10. Dout is the read data of next address.
  - 11. If CS# is low during this period, I/O pins are in the output state. Therefore, the input signals of the opposite phase to the outputs must not be applied to them.
  - 12. In the write cycle with OE# low fixed,  $t_{WP}$  must satisfy the following equation to avoid a problem of data bus contention.  $t_{WP} \ge t_{DW} \min + t_{WHZ} \max$

# **Timing Waveform**

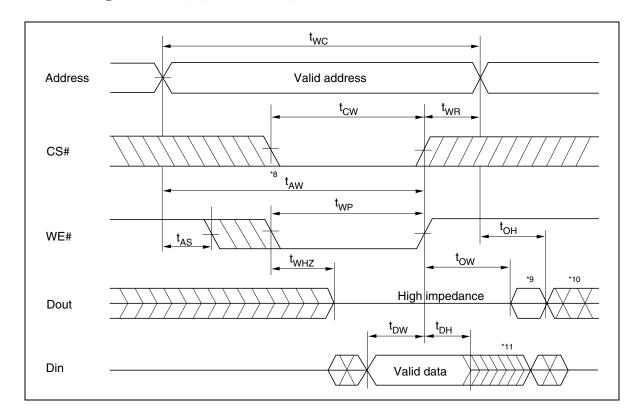
# Read Timing Waveform (WE# = $V_{IH}$ )



# Write Timing Waveform (1) (OE# Clock)



# Write Timing Waveform (2) (OE# Low Fixed)



### Low V<sub>CC</sub> Data Retention Characteristics

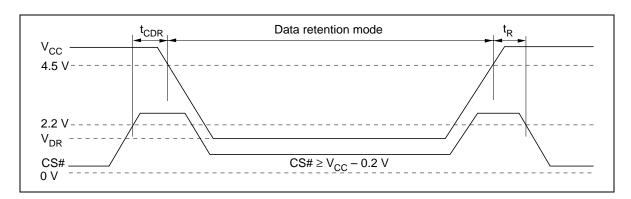
 $(Ta = -40 \text{ to } +85^{\circ}C)$ 

Parameter			Symbol	Min	Тур	Max	Unit	Test conditions*3
V <sub>CC</sub> for da	ta retention	l	$V_{DR}$	2	_	_	V	$CS\# \geq V_{CC} - 0.2 \text{ V, Vin} \geq 0 \text{ V}$
Data	-5SI	to +85°C	I <sub>CCDR</sub>		_	10	μΑ	V <sub>CC</sub> = 3.0 V, Vin ≥ 0 V
retention current		to +70°C	I <sub>CCDR</sub>	_	_	8	μΑ	CS# ≥ V <sub>CC</sub> – 0.2 V
ourront		to +40°C	I <sub>CCDR</sub>		1.0*2	3	μΑ	-
		to +25°C	I <sub>CCDR</sub>		0.8*1	3	μΑ	
	-7LI	to +85°C	I <sub>CCDR</sub>		_	20	μΑ	-
		to +70°C	I <sub>CCDR</sub>		_	16	μΑ	
		to +40°C	I <sub>CCDR</sub>		1.0*2	10	μΑ	
		to +25°C	I <sub>CCDR</sub>	_	0.8*1	10	μΑ	
Chip deselect to data retention time		t <sub>CDR</sub>	0	_	_	ns	See retention waveform	
Operation recovery time		t <sub>R</sub>	t <sub>RC</sub> *	<b>'</b> —	_	ns	-	

Notes: 1. Typical values are at  $V_{CC} = 3.0 \text{ V}$ ,  $Ta = +25^{\circ}\text{C}$  and specified loading, and not guaranteed.

- 2. Typical values are at  $V_{CC} = 3.0 \text{ V}$ ,  $Ta = +40^{\circ}\text{C}$  and specified loading, and not guaranteed.
- 3. CS# controls address buffer, WE# buffer, OE# buffer, and Din buffer. In data retention mode, Vin levels (address, WE#, OE#, I/O) can be in the high impedance state.
- 4.  $t_{RC}$  = read cycle time.

### $Low~V_{CC}~Data~Retention~Timing~Waveform~(CS\#~Controlled)$



# **Revision History**

# R1LP0408C-I Series Data Sheet

Rev.	Date	Contents of Modification						
		Page	Description					
1.00	Aug.01.2003	_	Initial issue					
2.00	May.26.2004	6	DC characteristics -5SI and -7LI items' description are divided.					
		12	Low V <sub>CC</sub> Data Retention Characteristics –5SI and –7LI items' description are divided.					
		12	Low $V_{CC}$ Data Retention Timing Waveform 2.4 V to 2.2 V					

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